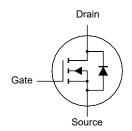
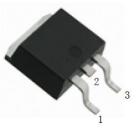
WDR10N090LS-CH

N-Channel Enhancement Mode MOSFET

Features

- Low RDS(ON)
- AEC-Q101 Qualified
- · Surface-mounted package
- Low Gate-Source Threshold Voltage
- Halogen and Antimony Free(HAF), RoHS compliant





1.Gate 2.Drain 3.Source TO-252 Plastic Package

Key Parameters

Parameter	Value	Unit		
BV _{DSS}	100	V		
D. Mari	9.5 @ V _{GS} = 10 V	mΩ		
R _{DS(ON)} Max	13 @ V _{GS} = 4.5 V			
V _{GS(th)} typ	1.6	V		
Q _g typ	38 @ V _{GS} = 10 V	nC		

Absolute Maximum Ratings(at Ta = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{ extsf{DS}}$	100	V
Gate-Source Voltage	V _G s	± 20	V
Drain Current	lь	56 39	Α
Peak Drain Current, Pulsed 1)	Ірм	200	Α
Avalanche Current	I _{AS}	16.8	Α
Single Pulse Avalanche Energy 2)	Eas	70.5	mJ
Total Power Dissipation	P _{tot}	57.6	W
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to + 175	°C

Thermal Characteristics

Parameter	Symbol	Max.	Unit	
Thermal Resistance from Junction to Case	R _{θJC}	2.6	°C/W	
Thermal Resistance from Junction to Ambient 3)	Reja	35	°C/W	

¹⁾ Pulse Test: Pulse Width ≤ 100 μs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ = 175°C.



 $^{^{2)}}$ Limited by $T_{J(MAX)},$ starting T_J = 25°C, L = 0.5 mH, R_g = 25 $\Omega,\,I_{AS}$ = 16.8 A, V_{GS} = 10 V.

³⁾ Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate in still air.

WDR10N090LS-CH

Characteristics at Ta = 25°C unless otherwise specified

Parameter	Symbol	Min.	Тур.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at I_D = 250 μ A	BV _{DSS}	100	-	-	V
Drain-Source Leakage Current at V _{DS} = 80 V	I _{DSS}	-	-	1	μΑ
Gate Leakage Current at V _{GS} = ± 20 V	I _{GSS}	-	-	± 100	nA
Gate-Source Threshold Voltage at V_{DS} = V_{GS} , I_D = 250 μ A	V _{GS(th)}	1.2	-	2.5	V
Drain-Source On-State Resistance at V_{GS} = 10 V, I_D = 15 A at V_{GS} = 4.5 V, I_D = 10 A	R _{DS(on)}	-	7.5 -	9.5 13	mΩ
DYNAMIC PARAMETERS					
Forward Transconductance at V _{DS} = 5 V, I _D = 10 A	g fs	-	28.7	-	S
Gate Resistance at $V_{GS} = 0 \text{ V}$, $V_{DS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Rg	-	0.8	-	Ω
Input Capacitance at V _{GS} = 0 V, V _{DS} = 50 V, f = 1 MHz	C _{iss}	-	1685	-	pF
Output Capacitance at $V_{GS} = 0 \text{ V}$, $V_{DS} = 50 \text{ V}$, $f = 1 \text{ MHz}$	Coss	-	307	-	pF
Reverse Transfer Capacitance at V _{GS} = 0 V, V _{DS} = 50 V, f = 1 MHz	Crss	-	24	-	pF
Gate charge total at V_{DS} = 50 V, V_{GS} = 10 V, I_D = 15 A at V_{DS} = 50 V, V_{GS} = 4.5 V, I_D = 15 A	Q_g		38 20	- -	nC
Gate to Source Charge at V_{DS} = 50 V, V_{GS} = 10 V, I_D = 15 A	Q _{gs}	-	5.6	-	nC
Gate to Drain Charge at V_{DS} = 50 V, V_{GS} = 10 V, I_D = 15 A	Q_{gd}	-	11	-	nC
Turn-On Delay Time at V_{DS} = 50 V, V_{GS} = 10 V, I_D = 15 A, R_g = 3.3 Ω	t _{d(on)}	-	14.5	-	ns
Turn-On Rise Time at V_{DS} = 50 V, V_{GS} = 10 V, I_D = 15 A, R_g = 3.3 Ω	t _r	-	15.5	-	ns
Turn-Off Delay Time at V_{DS} = 50 V, V_{GS} = 10 V, I_D = 15 A, R_g = 3.3 Ω	$t_{d(off)}$	-	15	-	ns
Turn-Off Fall Time at V_{DS} = 50 V, V_{GS} = 10 V, I_D = 15 A, R_g = 3.3 Ω	t _f	-	4	-	ns
Body-Diode PARAMETERS					
Drain-Source Diode Forward Voltage at $I_S = 1 A$, $V_{GS} = 0 V$	V _{SD}	-	-	1	V
Body-Diode Continuous Current	ls	-	-	56	Α
Body-Diode Continuous Current, Pulsed	I _{SM}	-	-	200	Α
Body Diode Reverse Recovery Time at Is = 15 A, di/dt = 100 A / µs	t _{rr}	-	40	-	ns
Body Diode Reverse Recovery Charge at I _S = 15 A, di/dt = 100 A / µs	Qrr	-	38	-	nC



Electrical Characteristics Curves

Fig. 1 Typical Output Characteristics

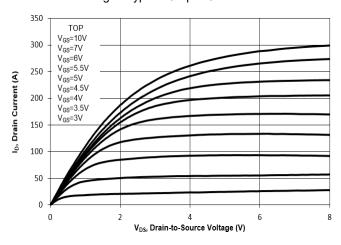


Fig. 2 Typical Transfer Characteristics

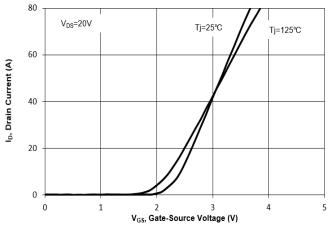


Fig. 3 On-Resistance vs. Drain Current

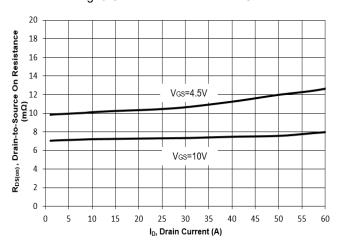


Fig. 4 On-Resistance vs. Gate to Source Voltage

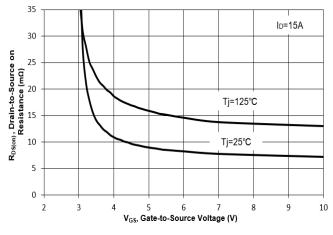


Fig. 5 On-Resistance vs.T_j

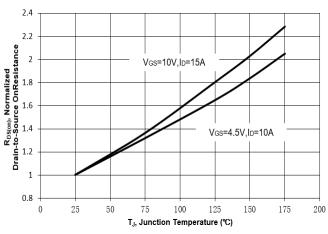
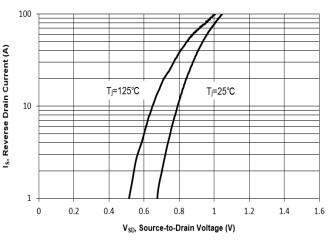
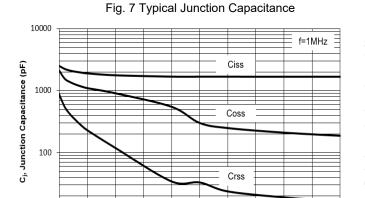


Fig. 6 Typical Body-Diode Forward Characteristics





Electrical Characteristics Curves



100 V_{DS}=100V

Fig. 8 Drain-Source Leakage Current vs. Ti

Fig. 9 $V_{(BR)DSS}$ vs. Junction Temperature

V_{DS}, Drain-Source Voltage (V)

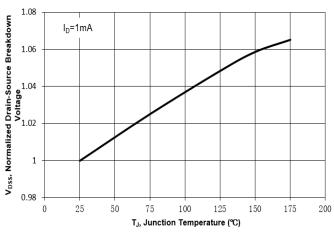


Fig. 10 Gate Threshold Variation vs. T_j

T_J, Junction Temperature (℃)

0.01 \(\triangle 0.01 \)

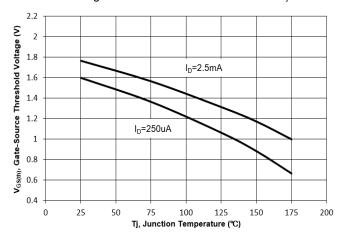


Fig. 11 Gate Charge

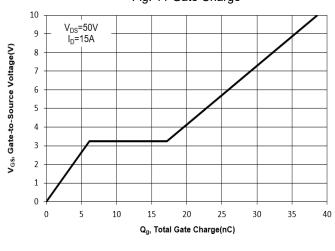
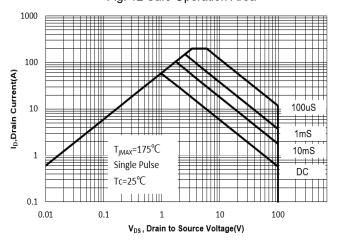


Fig. 12 Safe Operation Area





Electrical Characteristics Curves

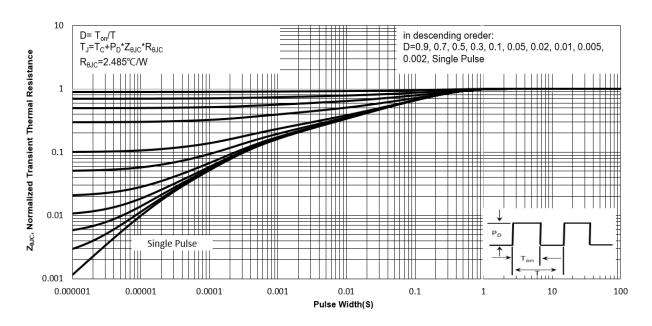
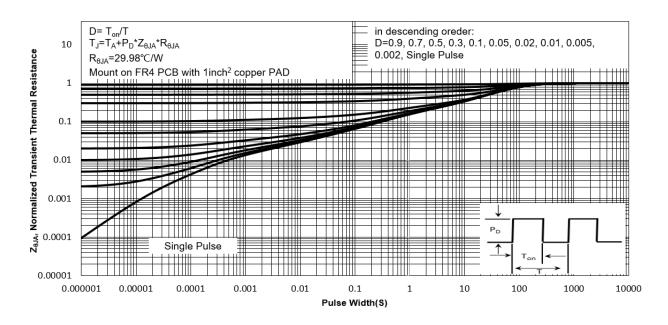
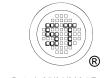


Fig. 13 Normalized Maximum Transient Thermal Impedance(zeuc)

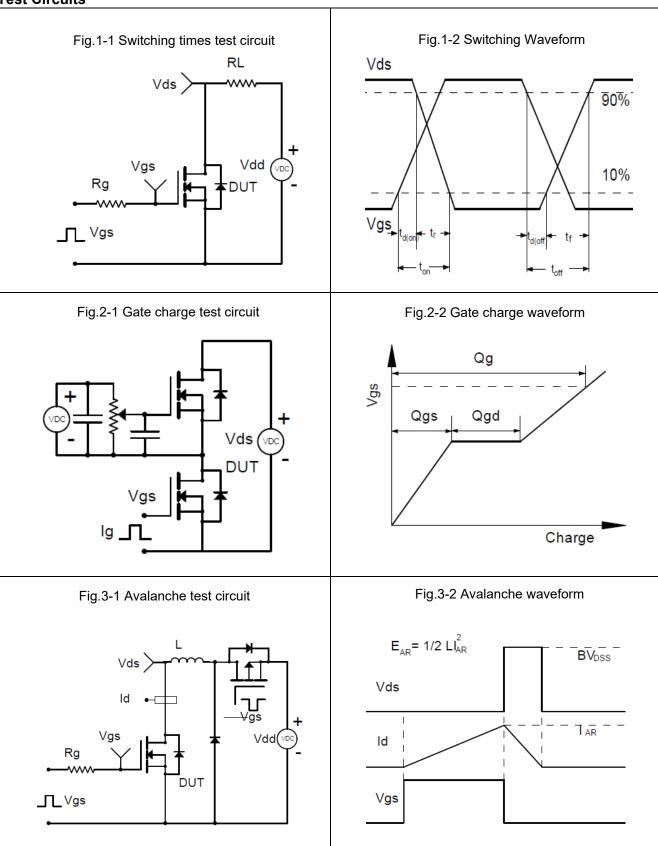






WDR10N090LS-CH

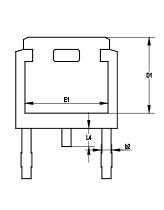
Test Circuits

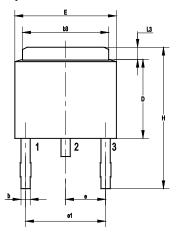


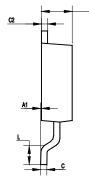


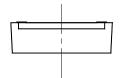
Package Outline (Dimensions in mm)

TO-252



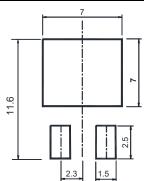






UNIT	Α	A1	b	b2	b3	С	C2	D	D1	Е	E1	е	e1	Н	L	L3	L4
	2.5	0.15	1.0	1.15	5.5	0.65	0.65	6.2	5.4	6.7	5.0	2.30	4.60	10.7	1.78	1.20	1.10
mm	2.1	0	0.5	0.65	4.9	0.4	0.4	5.6	5.0	6.1	4.6	TYP.	TYP.	9	1.40	0.85	0.51

Recommended Soldering Footprint



Packing information

Dookogo	Package Tape Width		Tape Width Pitch		Reel	Size	Per Reel Packing Quantity	
Package	(mm)	mm	inch	mm inch				
TO-252	16	8 ± 0.1	0.315 ± 0.004	330	13	2,500		

Marking information

" DR10N090LS " = Part No.

" ***** " = Date Code Marking

Font type: Arial



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